

**Search Notes**

Application/Control No.

10/526,400

Examiner

Nam Huynh

Applicant(s)/Patent under  
Reexamination

POYKKO ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
455	456.1	3/24/2006	NTH
	456.5		
	456.6		
	403		
342	357.1	3/24/2006	NTH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search notes.	3/24/2006	NTH